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Intel - EP20K60EQC208-2X Datasheet



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Details	
Product Status	Obsolete
Number of LABs/CLBs	2560
Number of Logic Elements/Cells	2560
Total RAM Bits	32768
Number of I/O	148
Number of Gates	162000
Voltage - Supply	1.71V ~ 1.89V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	208-BFQFP
Supplier Device Package	208-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k60eqc208-2x

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General Description

APEX[™] 20K devices are the first PLDs designed with the MultiCore architecture, which combines the strengths of LUT-based and productterm-based devices with an enhanced memory structure. LUT-based logic provides optimized performance and efficiency for data-path, registerintensive, mathematical, or digital signal processing (DSP) designs. Product-term-based logic is optimized for complex combinatorial paths, such as complex state machines. LUT- and product-term-based logic combined with memory functions and a wide variety of MegaCore and AMPP functions make the APEX 20K device architecture uniquely suited for system-on-a-programmable-chip designs. Applications historically requiring a combination of LUT-, product-term-, and memory-based devices can now be integrated into one APEX 20K device.

APEX 20KE devices are a superset of APEX 20K devices and include additional features such as advanced I/O standard support, CAM, additional global clocks, and enhanced ClockLock clock circuitry. In addition, APEX 20KE devices extend the APEX 20K family to 1.5 million gates. APEX 20KE devices are denoted with an "E" suffix in the device name (e.g., the EP20K1000E device is an APEX 20KE device). Table 8 compares the features included in APEX 20K and APEX 20KE devices. Figure 11 shows the intersection of a row and column interconnect, and how these forms of interconnects and LEs drive each other.



Figure 11. Driving the FastTrack Interconnect

APEX 20KE devices include an enhanced interconnect structure for faster routing of input signals with high fan-out. Column I/O pins can drive the FastRow[™] interconnect, which routes signals directly into the local interconnect without having to drive through the MegaLAB interconnect. FastRow lines traverse two MegaLAB structures. Also, these pins can drive the local interconnect directly for fast setup times. On EP20K300E and larger devices, the FastRow interconnect drives the two MegaLABs in the top left corner, the two MegaLABs in the top right corner, the two MegaLABS in the bottom left corner, and the two MegaLABs in the bottom right corner. On EP20K200E and smaller devices, FastRow interconnect drives the two MegaLABs on the top and the two MegaLABs on the bottom of the device. On all devices, the FastRow interconnect drives all local interconnect in the appropriate MegaLABs except the local interconnect on the side of the MegaLAB opposite the ESB. Pins using the FastRow interconnect achieve a faster set-up time, as the signal does not need to use a MegaLAB interconnect line to reach the destination LE. Figure 12 shows the FastRow interconnect.



Figure 14. APEX 20K Macrocell

For registered functions, each macrocell register can be programmed individually to implement D, T, JK, or SR operation with programmable clock control. The register can be bypassed for combinatorial operation. During design entry, the designer specifies the desired register type; the Quartus II software then selects the most efficient register operation for each registered function to optimize resource utilization. The Quartus II software or other synthesis tools can also select the most efficient register operation automatically when synthesizing HDL designs.

Each programmable register can be clocked by one of two ESB-wide clocks. The ESB-wide clocks can be generated from device dedicated clock pins, global signals, or local interconnect. Each clock also has an associated clock enable, generated from the local interconnect. The clock and clock enable signals are related for a particular ESB; any macrocell using a clock also uses the associated clock enable.

If both the rising and falling edges of a clock are used in an ESB, both ESB-wide clock signals are used.

The programmable register also supports an asynchronous clear function. Within the ESB, two asynchronous clears are generated from global signals and the local interconnect. Each macrocell can either choose between the two asynchronous clear signals or choose to not be cleared. Either of the two clear signals can be inverted within the ESB. Figure 15 shows the ESB control logic when implementing product-terms.



Figure 15. ESB Product-Term Mode Control Logic

(1) APEX 20KE devices have four dedicated clocks.

Parallel Expanders

Parallel expanders are unused product terms that can be allocated to a neighboring macrocell to implement fast, complex logic functions. Parallel expanders allow up to 32 product terms to feed the macrocell OR logic directly, with two product terms provided by the macrocell and 30 parallel expanders provided by the neighboring macrocells in the ESB.

The Quartus II software Compiler can allocate up to 15 sets of up to two parallel expanders per set to the macrocells automatically. Each set of two parallel expanders incurs a small, incremental timing delay. Figure 16 shows the APEX 20K parallel expanders.

Read/Write Clock Mode

The read/write clock mode contains two clocks. One clock controls all registers associated with writing: data input, WE, and write address. The other clock controls all registers associated with reading: read enable (RE), read address, and data output. The ESB also supports clock enable and asynchronous clear signals; these signals also control the read and write registers independently. Read/write clock mode is commonly used for applications where reads and writes occur at different system frequencies. Figure 20 shows the ESB in read/write clock mode.



Notes to Figure 20:

- (1) All registers can be cleared asynchronously by ESB local interconnect signals, global signals, or the chip-wide reset.
- (2) APEX 20KE devices have four dedicated clocks.

Input/Output Clock Mode

The input/output clock mode contains two clocks. One clock controls all registers for inputs into the ESB: data input, WE, RE, read address, and write address. The other clock controls the ESB data output registers. The ESB also supports clock enable and asynchronous clear signals; these signals also control the reading and writing of registers independently. Input/output clock mode is commonly used for applications where the reads and writes occur at the same system frequency, but require different clock enable signals for the input and output registers. Figure 21 shows the ESB in input/output clock mode.



Figure 21. ESB in Input/Output Clock Mode

Notes to Figure 21:

All registers can be cleared asynchronously by ESB local interconnect signals, global signals, or the chip-wide reset. (1)APEX 20KE devices have four dedicated clocks. (2)

Single-Port Mode

The APEX 20K ESB also supports a single-port mode, which is used when simultaneous reads and writes are not required. See Figure 22.

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For designs that require both a multiplied and non-multiplied clock, the clock trace on the board can be connected to CLK2p. Table 14 shows the combinations supported by the ClockLock and ClockBoost circuitry. The CLK2p pin can feed both the ClockLock and ClockBoost circuitry in the APEX 20K device. However, when both circuits are used, the other clock pin (CLK1p) cannot be used.

Table 14. Multiplication Factor Combinations					
Clock 1	Clock 2				
×1	×1				
×1, ×2	×2				
×1, ×2, ×4	×4				

APEX 20KE ClockLock Feature

APEX 20KE devices include an enhanced ClockLock feature set. These devices include up to four PLLs, which can be used independently. Two PLLs are designed for either general-purpose use or LVDS use (on devices that support LVDS I/O pins). The remaining two PLLs are designed for general-purpose use. The EP20K200E and smaller devices have two PLLs; the EP20K300E and larger devices have four PLLs.

The following sections describe some of the features offered by the APEX 20KE PLLs.

External PLL Feedback

The ClockLock circuit's output can be driven off-chip to clock other devices in the system; further, the feedback loop of the PLL can be routed off-chip. This feature allows the designer to exercise fine control over the I/O interface between the APEX 20KE device and another high-speed device, such as SDRAM.

Clock Multiplication

The APEX 20KE ClockBoost circuit can multiply or divide clocks by a programmable number. The clock can be multiplied by $m/(n \times k)$ or $m/(n \times v)$, where *m* and *k* range from 2 to 160, and *n* and *v* range from 1 to 16. Clock multiplication and division can be used for time-domain multiplexing and other functions, which can reduce design LE requirements.

Notes to Table 16:

- (1) To implement the ClockLock and ClockBoost circuitry with the Quartus II software, designers must specify the input frequency. The Quartus II software tunes the PLL in the ClockLock and ClockBoost circuitry to this frequency. The *f_{CLKDEV}* parameter specifies how much the incoming clock can differ from the specified frequency during device operation. Simulation does not reflect this parameter.
- (2) Twenty-five thousand parts per million (PPM) equates to 2.5% of input clock period.
- (3) During device configuration, the ClockLock and ClockBoost circuitry is configured before the rest of the device. If the incoming clock is supplied during configuration, the ClockLock and ClockBoost circuitry locks during configuration because the t_{LOCK} value is less than the time required for configuration.
- (4) The t_{IITTER} specification is measured under long-term observation.

Tables 17 and 18 summarize the ClockLock and ClockBoost parameters for APEX 20KE devices.

Table 17. API	Table 17. APEX 20KE ClockLock & ClockBoost Parameters Note (1)								
Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
t _R	Input rise time				5	ns			
t _F	Input fall time				5	ns			
t _{INDUTY}	Input duty cycle		40		60	%			
t _{INJITTER}	Input jitter peak-to-peak				2% of input period	peak-to- peak			
	Jitter on ClockLock or ClockBoost- generated clock				0.35% of output period	RMS			
t _{outduty}	Duty cycle for ClockLock or ClockBoost-generated clock		45		55	%			
t _{LOCK} <i>(2)_, (3)</i>	Time required for ClockLock or ClockBoost to acquire lock				40	μs			

Table 18. APEX 20KE Clock Input & Output Parameters (Part 1 of 2) Note (1)							
Symbol	Parameter	I/O Standard	-1X Speed Grade		-2X Speed Grade		Units
			Min	Max	Min	Max	
f _{VCO} (4)	Voltage controlled oscillator operating range		200	500	200	500	MHz
f _{CLOCK0}	Clock0 PLL output frequency for internal use		1.5	335	1.5	200	MHz
f _{CLOCK1}	Clock1 PLL output frequency for internal use		20	335	20	200	MHz
f _{CLOCK0_EXT}	Output clock frequency for	3.3-V LVTTL	1.5	245	1.5	226	MHz
	external clock0 output	2.5-V LVTTL	1.5	234	1.5	221	MHz
		1.8-V LVTTL	1.5	223	1.5	216	MHz
		GTL+	1.5	205	1.5	193	MHz
		SSTL-2 Class I	1.5	158	1.5	157	MHz
		SSTL-2 Class II	1.5	142	1.5	142	MHz
		SSTL-3 Class I	1.5	166	1.5	162	MHz
		SSTL-3 Class II	1.5	149	1.5	146	MHz
		LVDS	1.5	420	1.5	350	MHz
f _{CLOCK1_EXT}	Output clock frequency for	3.3-V LVTTL	20	245	20	226	MHz
	external clock1 output	2.5-V LVTTL	20	234	20	221	MHz
		1.8-V LVTTL	20	223	20	216	MHz
		GTL+	20	205	20	193	MHz
		SSTL-2 Class I	20	158	20	157	MHz
		SSTL-2 Class II	20	142	20	142	MHz
		SSTL-3 Class I	20	166	20	162	MHz
		SSTL-3 Class II	20	149	20	146	MHz
		LVDS	20	420	20	350	MHz

Table 2	Table 26. APEX 20K 5.0-V Tolerant Device Capacitance Notes (2), (14)							
Symbol	Parameter	Conditions	Min	Max	Unit			
C _{IN}	Input capacitance	V _{IN} = 0 V, f = 1.0 MHz		8	pF			
CINCLK	Input capacitance on dedicated clock pin	V _{IN} = 0 V, f = 1.0 MHz		12	pF			
C _{OUT}	Output capacitance	V _{OUT} = 0 V, f = 1.0 MHz		8	pF			

Notes to Tables 23 through 26:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- All APEX 20K devices are 5.0-V tolerant. (2)
- (3) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- Numbers in parentheses are for industrial-temperature-range devices. (4)
- Maximum V_{CC} rise time is 100 ms, and V_{CC} must rise monotonically. (5)
- All pins, including dedicated inputs, clock I/O, and JTAG pins, may be driven before V_{CCINT} and V_{CCIO} are (6) powered.
- (7)Typical values are for $T_A = 25^{\circ}$ C, $V_{CCINT} = 2.5$ V, and $V_{CCIO} = 2.5$ or 3.3 V.
- These values are specified in the APEX 20K device recommended operating conditions, shown in Table 26 on (8)page 62.
- (9) The APEX 20K input buffers are compatible with 2.5-V and 3.3-V (LVTTL and LVCMOS) signals. Additionally, the input buffers are 3.3-V PCI compliant when V_{CCIO} and V_{CCINT} meet the relationship shown in Figure 33 on page 68.
- (10) The I_{OH} parameter refers to high-level TTL, PCI or CMOS output current.
- (11) The I_{OL} parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (12) This value is specified for normal device operation. The value may vary during power-up.
- (13) Pin pull-up resistance values will be lower if an external source drives the pin higher than V_{CCIO} .
- (14) Capacitance is sample-tested only.

Tables 27 through 30 provide information on absolute maximum ratings, recommended operating conditions, DC operating conditions, and capacitance for 1.8-V APEX 20KE devices.

Table 2	Table 27. APEX 20KE Device Absolute Maximum Ratings Note (1)							
Symbol	Parameter	Conditions	Min	Max	Unit			
V _{CCINT}	Supply voltage	With respect to ground (2)	-0.5	2.5	V			
V _{CCIO}			-0.5	4.6	V			
VI	DC input voltage		-0.5	4.6	V			
I _{OUT}	DC output current, per pin		-25	25	mA			
T _{STG}	Storage temperature	No bias	-65	150	°C			
T _{AMB}	Ambient temperature	Under bias	-65	135	°C			
Τ _J	Junction temperature	PQFP, RQFP, TQFP, and BGA packages, under bias		135	°C			
		Ceramic PGA packages, under bias		150	°C			



Figure 34 shows the typical output drive characteristics of APEX 20K devices with 3.3-V and 2.5-V V_{CCIO}. The output driver is compatible with the 3.3-V *PCI Local Bus Specification, Revision 2.2* (when VCCIO pins are connected to 3.3 V). 5-V tolerant APEX 20K devices in the -1 speed grade are 5-V PCI compliant over all operating conditions.







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Figure 40. Synchronous Bidirectional Pin External Timing

Notes to Figure 40:

- (1) The output enable and input registers are LE registers in the LAB adjacent to a bidirectional row pin. The output enable register is set with "Output Enable Routing= Signal-Pin" option in the Quartus II software.
- (2) The LAB adjacent input register is set with "Decrease Input Delay to Internal Cells= Off". This maintains a zero hold time for lab adjacent registers while giving a fast, position independent setup time. A faster setup time with zero hold time is possible by setting "Decrease Input Delay to Internal Cells= ON" and moving the input register farther away from the bidirectional pin. The exact position where zero hold occurs with the minimum setup time, varies with device density and speed grade.

Table 31 describes the f_{MAX} timing parameters shown in Figure 36 on page 68.

Table 31. APEX 20K f _{MAX} Timing Parameters (Part 1 of 2)						
Symbol	Parameter					
t _{SU}	LE register setup time before clock					
t _H	LE register hold time after clock					
t _{CO}	LE register clock-to-output delay					
t _{LUT}	LUT delay for data-in					
t _{ESBRC}	ESB Asynchronous read cycle time					
t _{ESBWC}	ESB Asynchronous write cycle time					
t _{ESBWESU}	ESB WE setup time before clock when using input register					
t _{ESBDATASU}	ESB data setup time before clock when using input register					
t _{ESBDATAH}	ESB data hold time after clock when using input register					
t _{ESBADDRSU}	ESB address setup time before clock when using input registers					
t _{ESBDATACO1}	ESB clock-to-output delay when using output registers					

Table 31. APEX 2	OK f _{MAX} Timing Parameters (Part 2 of 2)			
Symbol	Parameter			
t _{ESBDATACO2}	ESB clock-to-output delay without output registers			
t _{ESBDD}	ESB data-in to data-out delay for RAM mode			
t _{PD}	ESB macrocell input to non-registered output			
t _{PTERMSU}	ESB macrocell register setup time before clock			
t _{PTERMCO}	ESB macrocell register clock-to-output delay			
t _{F1-4}	Fanout delay using local interconnect			
t _{F5-20}	Fanout delay using MegaLab Interconnect			
t _{F20+}	Fanout delay using FastTrack Interconnect			
t _{CH}	Minimum clock high time from clock pin			
t _{CL}	Minimum clock low time from clock pin			
t _{CLRP}	LE clear pulse width			
t _{PREP}	LE preset pulse width			
t _{ESBCH}	Clock high time			
t _{ESBCL}	Clock low time			
t _{ESBWP}	Write pulse width			
t _{ESBRP}	Read pulse width			

Tables 32 and 33 describe APEX 20K external timing parameters.

Table 32. APEX 20K External Timing Parameters Note (1)				
Symbol	Clock Parameter			
t _{INSU}	Setup time with global clock at IOE register			
t _{INH}	Hold time with global clock at IOE register			
t _{оитсо}	Clock-to-output delay with global clock at IOE register			

Table 33. APEX 20K External Bidirectional Timing Parameters Note (1)						
Symbol	Parameter	Conditions				
t _{INSUBIDIR}	Setup time for bidirectional pins with global clock at same-row or same- column LE register					
t _{INHBIDIR}	Hold time for bidirectional pins with global clock at same-row or same-column LE register					
^t OUTCOBIDIR	Clock-to-output delay for bidirectional pins with global clock at IOE register	C1 = 10 pF				
t _{XZBIDIR}	Synchronous IOE output buffer disable delay	C1 = 10 pF				
t _{ZXBIDIR}	Synchronous IOE output buffer enable delay, slow slew rate = off	C1 = 10 pF				

Tables 40 through 42 show the f_{MAX} timing parameters for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Symbol	-1 Snee	d Grade	-2 Snee	d Grade	-3 Sner	-3 Sneed Grade	
oymbol			2 0000		0 0000		
	Min	Max	Min	Max	Min	Max	
t _{SU}	0.5		0.6		0.8		ns
t _H	0.7		0.8		1.0		ns
t _{CO}		0.3		0.4		0.5	ns
t _{LUT}		0.8		1.0		1.3	ns
t _{ESBRC}		1.7		2.1		2.4	ns
t _{ESBWC}		5.7		6.9		8.1	ns
t _{ESBWESU}	3.3		3.9		4.6		ns
t _{ESBDATASU}	2.2		2.7		3.1		ns
t _{ESBDATAH}	0.6		0.8		0.9		ns
t _{ESBADDRSU}	2.4		2.9		3.3		ns
t _{ESBDATACO1}		1.3		1.6		1.8	ns
t _{ESBDATACO2}		2.6		3.1		3.6	ns
t _{ESBDD}		2.5		3.3		3.6	ns
t _{PD}		2.5		3.0		3.6	ns
t _{PTERMSU}	2.3		2.6		3.2		ns
t _{PTERMCO}		1.5		1.8		2.1	ns
t _{F1-4}		0.5		0.6		0.7	ns
t _{F5-20}		1.6		1.7		1.8	ns
t _{F20+}		2.2		2.2		2.3	ns
t _{CH}	2.0		2.5		3.0		ns
t _{CL}	2.0		2.5		3.0		ns
t _{CLRP}	0.3		0.4		0.4		ns
t _{PREP}	0.5		0.5		0.5		ns
t _{ESBCH}	2.0		2.5		3.0		ns
t _{ESBCL}	2.0		2.5		3.0		ns
t _{ESBWP}	1.6		1.9		2.2		ns
t _{ESBRP}	1.0		1.3		1.4		ns

Tables 55 through 60 describe f_{MAX} LE Timing Microparameters, f_{MAX} ESB Timing Microparameters, f_{MAX} Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K60E APEX 20KE devices.

Table 55. EP20K60E f _{MAX} LE Timing Microparameters								
Symbol	Symbol -1		-2			Unit		
	Min	Max	Min	Max	Min	Max		
t _{SU}	0.17		0.15		0.16		ns	
t _H	0.32		0.33		0.39		ns	
t _{CO}		0.29		0.40		0.60	ns	
t _{LUT}		0.77		1.07		1.59	ns	

Table 68. EP20K160E f _{MAX} ESB Timing Microparameters										
Symbol	-1		-2		-3		Unit			
	Min	Max	Min	Max	Min	Max				
t _{ESBARC}		1.65		2.02		2.11	ns			
t _{ESBSRC}		2.21		2.70		3.11	ns			
t _{ESBAWC}		3.04		3.79		4.42	ns			
t _{ESBSWC}		2.81		3.56		4.10	ns			
t _{ESBWASU}	0.54		0.66		0.73		ns			
t _{ESBWAH}	0.36		0.45		0.47		ns			
t _{ESBWDSU}	0.68		0.81		0.94		ns			
t _{ESBWDH}	0.36		0.45		0.47		ns			
t _{ESBRASU}	1.58		1.87		2.06		ns			
t _{ESBRAH}	0.00		0.00		0.01		ns			
t _{ESBWESU}	1.41		1.71		2.00		ns			
t _{ESBWEH}	0.00		0.00		0.00		ns			
t _{ESBDATASU}	-0.02		-0.03		0.09		ns			
t _{ESBDATAH}	0.13		0.13		0.13		ns			
t _{ESBWADDRSU}	0.14		0.17		0.35		ns			
t _{ESBRADDRSU}	0.21		0.27		0.43		ns			
t _{ESBDATACO1}		1.04		1.30		1.46	ns			
t _{ESBDATACO2}		2.15		2.70		3.16	ns			
t _{ESBDD}		2.69		3.35		3.97	ns			
t _{PD}		1.55		1.93		2.29	ns			
t _{PTERMSU}	1.01		1.23		1.52		ns			
t _{PTERMCO}		1.06		1.32		1.04	ns			

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Table 86. EP20k	Table 86. EP20K400E f _{MAX} ESB Timing Microparameters										
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit				
	Min	Max	Min	Max	Min	Max					
t _{ESBARC}		1.67		1.91		1.99	ns				
t _{ESBSRC}		2.30		2.66		2.93	ns				
t _{ESBAWC}		3.09		3.58		3.99	ns				
t _{ESBSWC}		3.01		3.65		4.05	ns				
t _{ESBWASU}	0.54		0.63		0.65		ns				
t _{ESBWAH}	0.36		0.43		0.42		ns				
t _{ESBWDSU}	0.69		0.77		0.84		ns				
t _{ESBWDH}	0.36		0.43		0.42		ns				
t _{ESBRASU}	1.61		1.77		1.86		ns				
t _{ESBRAH}	0.00		0.00		0.01		ns				
t _{ESBWESU}	1.35		1.47		1.61		ns				
t _{ESBWEH}	0.00		0.00		0.00		ns				
t _{ESBDATASU}	-0.18		-0.30		-0.27		ns				
t _{ESBDATAH}	0.13		0.13		0.13		ns				
t _{ESBWADDRSU}	-0.02		-0.11		-0.03		ns				
t _{ESBRADDRSU}	0.06		-0.01		-0.05		ns				
t _{ESBDATACO1}		1.16		1.40		1.54	ns				
t _{ESBDATACO2}		2.18		2.55		2.85	ns				
t _{ESBDD}		2.73		3.17		3.58	ns				
t _{PD}		1.57		1.83		2.07	ns				
t _{PTERMSU}	0.92		0.99		1.18		ns				
t _{PTERMCO}		1.18		1.43		1.17	ns				

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Table 87. EP20K400E f _{MAX} Routing Delays										
Symbol	-1 Spe	ed Grade	-2 Spe	ed Grade	-3 Spee	d Grade	Unit			
	Min	Max	Min	Max	Min	Max				
t _{F1-4}		0.25		0.25		0.26	ns			
t _{F5-20}		1.01		1.12		1.25	ns			
t _{F20+}		3.71		3.92		4.17	ns			

Symbol	Symbol -1 Speed Grade		-2 Spee	-2 Speed Grade		-3 Speed Grade		
	Min	Max	Min	Max	Min	Max		
t _{CH}	1.36		2.22		2.35		ns	
t _{CL}	1.36		2.26		2.35		ns	
t _{CLRP}	0.18		0.18		0.19		ns	
t _{PREP}	0.18		0.18		0.19		ns	
t _{ESBCH}	1.36		2.26		2.35		ns	
t _{ESBCL}	1.36		2.26		2.35		ns	
t _{ESBWP}	1.17		1.38		1.56		ns	
t _{ESBRP}	0.94		1.09		1.25		ns	

Table 89. EP20K400E External Timing Parameters											
Symbol	-1 Speed Grade		-2 Spee	-2 Speed Grade		-3 Speed Grade					
	Min	Max	Min	Max	Min	Max					
t _{INSU}	2.51		2.64		2.77		ns				
t _{INH}	0.00		0.00		0.00		ns				
t _{outco}	2.00	5.25	2.00	5.79	2.00	6.32	ns				
t _{insupll}	3.221		3.38		-		ns				
t _{INHPLL}	0.00		0.00		-		ns				
t _{outcopll}	0.50	2.25	0.50	2.45	-	-	ns				

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Tables 97 through 102 describe f_{MAX} LE Timing Microparameters, f_{MAX} ESB Timing Microparameters, f_{MAX} Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K1000E APEX 20KE devices.

Table 97. EP20K1000E f _{MAX} LE Timing Microparameters										
Symbol	-1 Spee	ed Grade	-2 Spe	Speed Grade -3		d Grade	Unit			
	Min	Max	Min	Max	Min	Max				
t _{SU}	0.25		0.25		0.25		ns			
t _H	0.25		0.25		0.25		ns			
t _{CO}		0.28		0.32		0.33	ns			
t _{LUT}		0.80		0.95		1.13	ns			

Table 98. EP20K1000E f _{MAX} ESB Timing Microparameters										
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit			
	Min	Max	Min	Max	Min	Max				
t _{ESBARC}		1.78		2.02		1.95	ns			
t _{ESBSRC}		2.52		2.91		3.14	ns			
t _{ESBAWC}		3.52		4.11		4.40	ns			
t _{ESBSWC}		3.23		3.84		4.16	ns			
t _{ESBWASU}	0.62		0.67		0.61		ns			
t _{ESBWAH}	0.41		0.55		0.55		ns			
t _{ESBWDSU}	0.77		0.79		0.81		ns			
t _{ESBWDH}	0.41		0.55		0.55		ns			
t _{ESBRASU}	1.74		1.92		1.85		ns			
t _{ESBRAH}	0.00		0.01		0.23		ns			
t _{ESBWESU}	2.07		2.28		2.41		ns			
t _{ESBWEH}	0.00		0.00		0.00		ns			
t _{ESBDATASU}	0.25		0.27		0.29		ns			
t _{ESBDATAH}	0.13		0.13		0.13		ns			
t _{ESBWADDRSU}	0.11		0.04		0.11		ns			
t _{ESBRADDRSU}	0.14		0.11		0.16		ns			
t _{ESBDATACO1}		1.29		1.50		1.63	ns			
t _{ESBDATACO2}		2.55		2.99		3.22	ns			
t _{ESBDD}		3.12		3.57		3.85	ns			
t _{PD}		1.84		2.13		2.32	ns			
t _{PTERMSU}	1.08		1.19		1.32		ns			
t _{PTERMCO}		1.31		1.53		1.66	ns			

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